TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

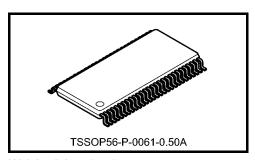
TC74VCX16827FT

Low-Voltage 20-Bit Bus Buffer with 3.6-V Tolerant Inputs and Outputs

The TC74VCX16827FT is a high-performance CMOS 20-bit bus buffer. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to $3.6\ V.$

The TC74VCX16827FT is composed of two 10-bit sections with separate output-enable signals. For either 10-bit buffer section, the two output-enable (10E1 and 10E2 or 20E1 and 20E2) inputs must both be low for the corresponding Y outputs to be active. When the $\overline{\rm OE}$ input is high, the outputs are in a high-impedance state. This device is designed to be used with 3-state memory address drivers, etc.



Weight: 0.25 g (typ.)

All inputs are equipped with protection circuits against static discharge.

Features

- Low-voltage operation: V_{CC} = 1.8 to 3.6 V
- High-speed operation: $t_{pd} = 2.5 \text{ ns (max) (V}_{CC} = 3.0 \text{ to } 3.6 \text{ V)}$

 $t_{pd} = 3.0 \text{ ns (max) (VCC} = 2.3 \text{ to } 2.7 \text{ V}$

 $t_{pd} = 6.0 \text{ ns (max) (V}_{CC} = 1.8 \text{ V})$

- Output current: $I_{OH}/I_{OL} = \pm 24 \text{ mA (min)} (V_{CC} = 3.0 \text{ V})$
 - : $I_{OH}/I_{OL} = \pm 18$ mA (min) ($V_{CC} = 2.3$ V)

: $I_{OH}/I_{OL} = \pm 6$ mA (min) ($V_{CC} = 1.8$ V)

- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200 \text{ V}$

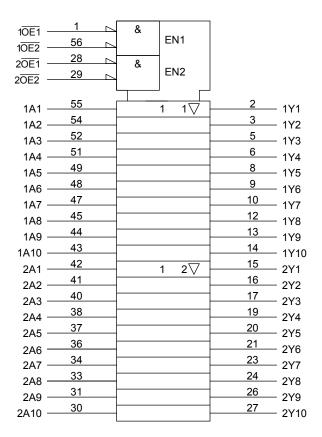
Human body model ≥ ±2000 V

- Package: TSSOP
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs

Pin Assignment (top view)

10E2 56 10E1 1Y1 2 55 1A1 3 1Y2 54 1A2 GND 4 **GND** 53 5 1Y3 52 1A3 1Y4 6 51 1A4 V_{CC} 7 V_{CC} 50 1Y5 8 49 1A5 1Y6 9 48 1A6 1Y7 10 47 1A7 GND 11 46 **GND** 1Y8 12 45 1A8 1Y9 13 1A9 1Y10 14 43 1A10 2Y1 15 2A1 42 2Y2 16 41 2A2 2Y3 17 40 2A3 GND 18 **GND** 39 2Y4 19 38 2A4 2Y5 20 37 2A5 2Y6 21 36 2A6 V_{CC} 22 35 V_{CC} 2Y7 23 34 2A7 2Y8 24 33 2A8 GND 25 **GND** 32 2Y9 26 2A9 31 2Y10 27 30 2A10 2OE1 28 2OE2 29

IEC Logic Symbol



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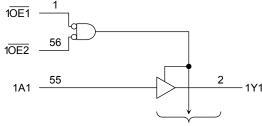
Truth Table (each 10-bit latch)

	Output		
ŌE1	OE2	Α	Y
L	L	L	L
L	L	Н	Н
Н	Х	Х	Z
X	Н	Х	Z

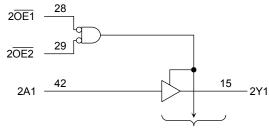
X: Don't care

Z: High impedance

System Diagram



To nine other channels



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To nine other channels

Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V_{CC}	-0.5 to 4.6	V
DC input voltage	V_{IN}	-0.5 to 4.6	V
		-0.5 to 4.6 (Note 2)	
DC output voltage	V_{OUT}	–0.5 to V _{CC} + 0.5	V
		(Note 3)	
Input diode current	l _{IK}	-50	mA
Output diode current	lok	±50 (Note 4)	mA
DC output current	lout	±50	mA
Power dissipation	P_{D}	400	mW
DC V _{CC} /ground current per supply pin	I _{CC} /I _{GND}	±100	mA
Storage temperature	T _{stg}	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: OFF state

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4: $V_{OUT} < GND, V_{OUT} > V_{CC}$

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CC}	1.8 to 3.6	V
Tower supply voltage	VCC	1.2 to 3.6 (Note 2)	v
Input voltage	V _{IN}	-0.3 to 3.6	V
Output voltage	V _{OUT}	0 to 3.6 (Note 3)	V
Output voltage	VOU1	0 to V _{CC} (Note 4)	V
		±24 (Note 5)	
Output current	I _{OH} /I _{OL}	±18 (Note 6)	mA
		±6 (Note 7)	
Operating temperature	T _{opr}	-40 to 85	°C
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Note 2: Data retention only

Note 3: OFF state

Note 4: High or low state

Note 5: $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$

Note 6: $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$

Note 7: $V_{CC} = 1.8 \text{ V}$

Note 8: $V_{IN} = 0.8$ to 2.0 V, $V_{CC} = 3.0$ V



Electrical Characteristics

DC Characteristics (Ta = -40 to 85°C, 2.7 V < $V_{CC} \leq 3.6 \ V)$

Characteris	stics	Symbol	Test Condition		V _{CC} (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	-		2.7 to 3.6	2.0	_	V
Input voltage	L-level	V _{IL}	-	_	2.7 to 3.6	_	0.8	V
				$I_{OH} = -100 \mu A$	2.7 to 3.6	V _{CC} - 0.2		
	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -12 mA	2.7	2.2	_	
				$I_{OH} = -18 \text{ mA}$	3.0	2.4		
Output voltage				$I_{OH} = -24 \text{ mA}$	3.0	2.2		٧
		el V _{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 100 \ \mu A$	2.7 to 3.6	_	0.2	
	L-level			$I_{OL} = 12 \text{ mA}$	2.7	_	0.4	
	L-level			$I_{OL} = 18 \text{ mA}$	3.0	_	0.4	
				$I_{OL} = 24 \text{ mA}$	3.0	_	0.55	
Input leakage currer	nt	I _{IN}	V _{IN} = 0 to 3.6 V		2.7 to 3.6	_	±5.0	μΑ
3-state output OFF state current		I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = 0 to 3.6 V		2.7 to 3.6	_	±10.0	μА
Power-off leakage current		I _{OFF}	V_{IN} , $V_{OUT} = 0$ to 3.6 V		0	_	10.0	μΑ
Quioscont supply ou	Quiescent supply current		V _{IN} = V _{CC} or GND		2.7 to 3.6	_	20.0	
Quiescent supply cu			$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.6 \text{ V}$		2.7 to 3.6	_	±20.0	μΑ
Increase in I _{CC} per i	input	Δlcc	$V_{IH} = V_{CC} - 0.6 V$ (per	input)	2.7 to 3.6	_	750	

DC Characteristics (Ta = -40 to 85°C, 2.3 V \leq V_{CC} \leq 2.7 V)

Characte	ristics	Symbol	Test	Condition	V _{CC} (V)	Min	Max	Unit			
	H-level	V _{IH}		_	2.3 to 2.7	1.6	_				
Input voltage	L-level	V _{IL}		_	2.3 to 2.7	_	0.7	V			
				I _{OH} = -100 μA	2.3 to 2.7	V _{CC} - 0.2	_				
	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -6 mA	2.3	2.0	_				
Output voltage			I _{OH} = -12 mA	2.3	1.8	_					
				I _{OH} = -18 mA	2.3	1.7	_	V			
			V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	2.3 to 2.7	_	0.2				
	L-level	V _{OL}		$V_{IN} = V_{IH}$ or V_{IL}	$V_{IN} = V_{IH} \ or \ V_{IL}$	$V_{IN} = V_{IH} \ or \ V_{IL}$	I _{OL} = 12 mA	2.3	_	0.4	
				I _{OL} = 18 mA	2.3	_	0.6				
Input leakage curre	ent	I _{IN}	V _{IN} = 0 to 3.6 V		2.3 to 2.7	_	±5.0	μА			
3-state output OFF state current		la-	$V_{IN} = V_{IH}$ or V_{IL}		2.3 to 2.7		±10.0				
		loz	V _{OUT} = 0 to 3.6 V		2.3 10 2.7	_	±10.0	μΑ			
Power-off leakage	current	loff	V _{IN} , V _{OUT} = 0 to 3.6 V		0		10.0	μА			
Outroport supply suppret			$V_{IN} = V_{CC}$ or GND		2.3 to 2.7		20.0	μА			
Quiescent supply	Current	Icc	V _{CC} ≤ (V _{IN} , V _{OUT}) ≤ 3.6 V		2.3 to 2.7	_	±20.0	μΑ			



DC Characteristics (Ta = -40 to 85° C, $1.8 \text{ V} \leq \text{V}_{CC} < 2.3 \text{ V}$)

Characteri	aracteristics Symbol Test Condition		ondition	V _{CC} (V)	Min	Max	Unit	
Input voltage	H-level	V _{IH}	-	_	1.8 to 2.3	0.7 × V _{CC}	_	V
input voitage	L-level	V _{IL}	-	_	1.8 to 2.3	_	0.2 × V _{CC}	V
	H-level	VoH	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.8	V _{CC} - 0.2		
Output voltage				I _{OH} = -6 mA	1.8	1.4	_	V
	L-level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	$I_{OL} = 100 \mu A$	1.8	_	0.2	
	L-IEVEI	VOL	AIM — AIH OL AIL	I _{OL} = 6 mA	1.8		0.3	
Input leakage curre	Input leakage current		V _{IN} = 0 to 3.6 V		1.8		±5.0	μΑ
3-state output OFF state current		I _{OZ}	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = 0$ to 3.6 V		1.8	_	±10.0	μΑ
Power-off leakage	current	l _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0	_	10.0	μА
Quiescent supply o	Quiescent supply current		V _{IN} = V _{CC} or GND		1.8	_	20.0	Δ
Quiescent supply c			$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.6 \text{ V}$		1.8		±20.0	μА

AC Characteristics (Ta = -40 to 85°C, input: $t_r = t_f = 2.0$ ns, $C_L = 30$ pF, $R_L = 500$ Ω) (Note 1)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
	4		1.8	1.5	6.0	
Propagation delay time	t _{pLH}	Figure 1, Figure 2	2.5 ± 0.2	1.0	3.0	ns
	t _{pHL}		3.3 ± 0.3	8.0	2.5	
	+		1.8	1.5	9.8	
3-state output enable time	t _{pZL} t _{pZH}	Figure 1, Figure 3	2.5 ± 0.2	1.0	4.9	ns
			3.3 ± 0.3	8.0	3.8	
	t	Figure 1, Figure 3	1.8	1.5	7.6	
3-state output disable time	t _{pLZ} t _{pHZ}		2.5 ± 0.2	1.0	4.2	ns
			3.3 ± 0.3	8.0	3.7	
Output to output skew	t _{osLH}	(Note 2)	1.8		0.5	
			2.5 ± 0.2		0.5	ns
	t _{osHL}		3.3 ± 0.3	_	0.5	

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Note 1: For $C_L = 50 \ pF$, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, \, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$



Dynamic Switching Characteristics

(Ta = 25°C, input: $t_r = t_f = 2.0 \text{ ns}, C_L = 30 \text{ pF}, R_L = 500 \Omega$)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Not		0.25	
Quiet output maximum dynamic VOI	V _{OLP}	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	2.5	0.6	V
dynamic VOL		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	9) 3.3	0.8	
	V _{OLV}	$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	9) 1.8	-0.25	V
Quiet output minimum dynamic V _{OI}		$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	2.5	-0.6	
, 01		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	3.3	-0.8	
		$V_{IH} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	1.8	1.5	
Quiet output minimum dynamic V _{OH}		$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	2.5	1.9	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Not	9) 3.3	2.2	

Note: Parameter guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

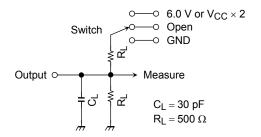
Characteristics	Symbol	Symbol Test Condition			Тур.	Unit
Characteristics	Symbol			V _{CC} (V)		
Input capacitance	C _{IN}	_		1.8, 2.5, 3.3	6	pF
Output capacitance	C _{OUT}	_		1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C _{PD}	$f_{IN} = 10 \text{ MHz}$ (N	lote)	1.8, 2.5, 3.3	20	pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/20 \text{ (per bit)}$

AC Test Circuit



Parameter	Switch		
t _{pLH} , t _{pHL}	Open		
t _{pLZ} , t _{pZL}	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$		
t _{pHZ} , t _{pZH}	GND		

Figure 1

AC Waveform

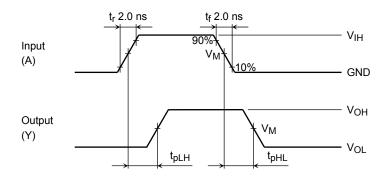


Figure 2 t_{pLH}, t_{pHL}

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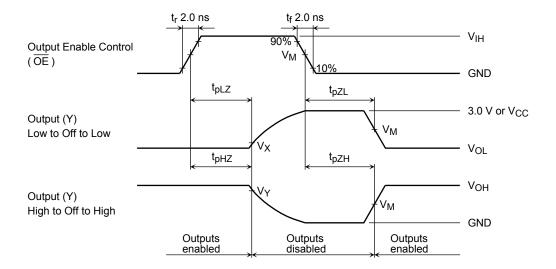


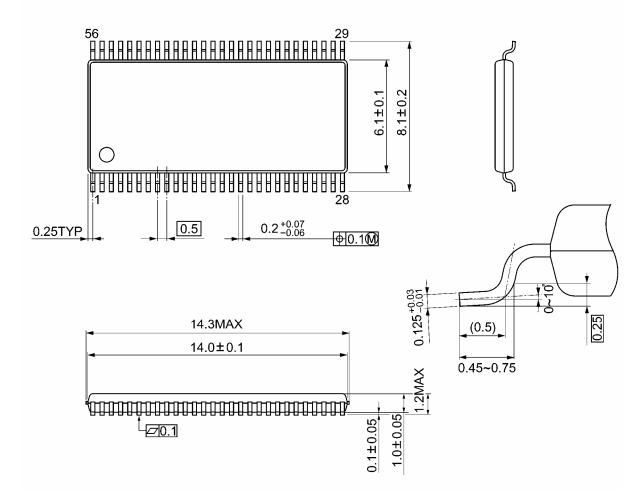
Figure 3 $\;t_{\text{pLZ}},\,t_{\text{pHZ}},\,t_{\text{pZL}},\,t_{\text{pZH}}$

Symbol	V _{CC}						
Symbol	$3.3\pm0.3~\textrm{V}$	$2.5\pm0.2\textrm{V}$	1.8 V				
V_{IH}	2.7 V	V _{CC}	V _{CC}				
V _M	1.5 V	V _{CC} /2	V _{CC} /2				
VX	V _{OL} + 0.3 V	V _{OL} + 0.15 V	V _{OL} + 0.15 V				
V _Y	V _{OH} – 0.3 V	V _{OH} – 0.15 V	V _{OH} – 0.15 V				

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Package Dimensions

TSSOP56-P-0061-0.50A Unit: mm



Weight: 0.25 g (typ.)

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20070701-EN GENERAL

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